



Advanced Technology Related to Radar Signal, Imaging, and Radar Cross-Section Measurement, Volume II

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Message from the Guest Editors

The aim of this Special Issue of Electronics is to present state-of-the-art investigations in various radar-important technologies for future applications. We invite researchers to contribute original and unique articles, as well as sophisticated review articles. Topics include, but are not limited to, the following areas:

- Radar imaging technology.
- Inverse synthetic aperture radar imaging.
- Inverse electromagnetic scattering.
- Short-distance radar.
- Collision-avoidance radar.
- Subsurface and ground penetrating radar.
- Microwave remote sensing image analysis.
- RCS near-field to far-field transformation.
- Radar electromagnetic modeling and simulation.
- Target recognition.
- Radar data fusion.





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Message from the Editor-in-Chief

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